

March 2013

FCP190N60 / FCPF190N60 N-Channel SuperFET® II MOSFET

600 V, 20.2 A, 199 mΩ

Features

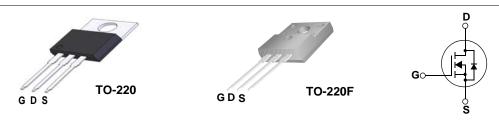
- 650 V @T_J = 150°C
- Max. $R_{DS(on)} = 199 \text{ m}\Omega$
- Ultra low gate charge (Typ. Q_g = 57 nC)
- Low effective output capacitance (Typ. C_{oss}.eff = 160 pF)
- 100% avalanche tested

Applications

- LCD / LED / PDP TV Lighting
- · Solar Inverter
- AC-CD Power Supply

Description

SuperFET[®]II MOSFET is Fairchild Semiconductor[®]'s first generation of high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, SuperFETII MOSFET is suitable for various AC/DC power conversion for system miniaturization and higher efficiency.



Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol		Parameter		FCP190N60	FCPF190N60	Unit
V _{DSS}	Drain to Source Voltage			6	00	V
\/	Coto to Course Voltage	-DC		±	20	V
V_{GSS}	Gate to Source Voltage	-AC	(f > 1 Hz)	±	30	V
1	Drain Current	-Continuous (T _C = 25°C)		20.2	20.2*	Α
ID	Drain Current	-Continuous (T _C = 100°C)		12.7	12.7*	А
I _{DM}	Drain Current	- Pulsed	(Note 1)	60.6	60.6*	Α
E _{AS}	Single Pulsed Avalanche Ene	ergy	(Note 2)	2) 400		mJ
I _{AR}	Avalanche Current (Note		(Note 1)	4.0		Α
E _{AR}	Repetitive Avalanche Energy		(Note 1)	1) 2.1		mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	3) 20		V/ns
uv/ui	MOSFET dv/dt			100		V/ns
D	Dower Discipation	(T _C = 25°C)		208	39	W
P_{D}	Power Dissipation	- Derate above 25°C		1.67	0.31	W/oC
T _J , T _{STG}	Operating and Storage Temp	erating and Storage Temperature Range -55 to +150		+150	°С	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		°C			
*Drain current lim	ited by maximum junction temperatu	re			'	

Thermal Characteristics

Symbol	Parameter	FCP190N60	FCPF190N60	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	0.6	3.2	
$R_{\theta CS}$	Thermal Resistance, Case to Heat Sink (Typical)		0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FCP190N60	FCP190N60	TO-220	-	-	50
FCPF190N60	FCPF190N60	TO-220F	-	-	50

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
D\/	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 25^{\circ}\text{C}$	600	-	-	V
BV _{DSS}	Dialii to Source Breakdowii voltage	$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 150^{\circ}\text{C}$	650	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 10 mA, Referenced to 25°C	-	0.67	-	V/°C
BV _{DS}	Drain-Source Avalanche Breakdown Voltage	V _{GS} = 0 V, I _D = 20 A	-	700	-	V
1	Zero Gate Voltage Drain Current	$V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 480 \text{ V}, T_{C} = 125^{\circ}\text{C}$	-	-	10	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	-	3.5	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	•	0.17	0.199	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 20 \text{ V}, I_{D} = 10 \text{ A}$	ı	21	-	S

Dynamic Characteristics

,						
C _{iss}	Input Capacitance	V 05.V.V 0.V	-	2220	2950	pF
C _{oss}	Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}$	=	1630	2165	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/12	-	85	128	pF
C _{oss}	Output Capacitance	$V_{DS} = 380 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	-	42	-	pF
C _{oss} eff.	Effective Output Capacitance	V _{DS} = 0 V to 480 V, V _{GS} = 0 V	-	160	-	pF
Q _{g(tot)}	Total Gate Charge at 10V	V _{DS} = 380 V, I _D = 10 A	-	57	74	nC
Q _{gs}	Gate to Source Gate Charge	V _{GS} = 10 V	-	9	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	(Note 4)	=	21	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz		1		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	20	50	ns
t _r		$V_{DD} = 380 \text{ V}, I_{D} = 10 \text{ A}$	-	10	30	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_g = 4.7 \Omega$	-	64	138	ns
t _f	Turn-Off Fall Time	(Note 4)	-	5	20	ns

Drain-Source Diode Characteristics

IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	20.2	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	60.6	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 10 A	-	-	1.2	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _{SD} = 10 A	-	280	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	-	3.8	-	μC

Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. I_{AS} = 4 A, V_{DD} = 50 V, R_G = 25 Ω , Starting T_J = 25°C
- 3. $I_{SD} \le 10$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

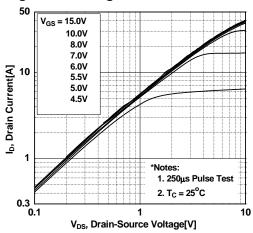


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

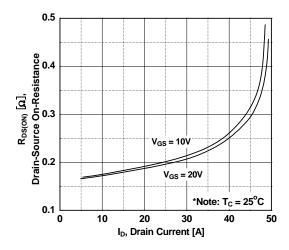


Figure 5. Capacitance Characteristics

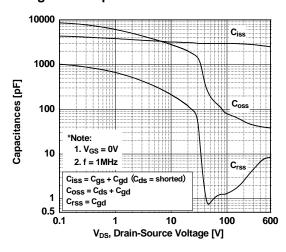


Figure 2. Transfer Characteristics

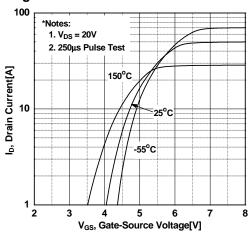


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

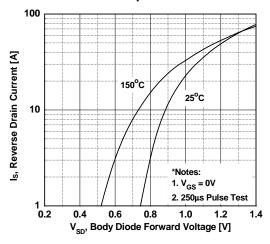
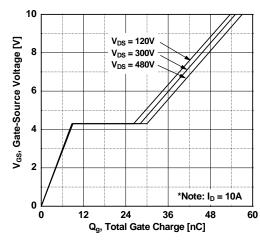


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

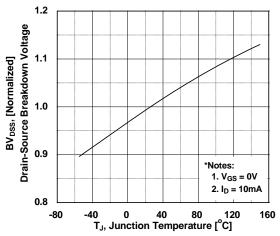


Figure 9. Maximum Safe Operating Area vs. Case Temperature - FCP190N60

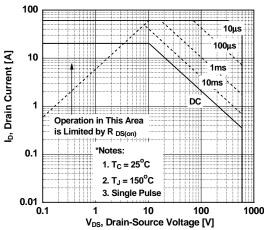


Figure 11. Maximum Drain Current

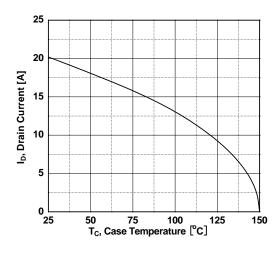


Figure 8. On-Resistance Variation vs. Temperature

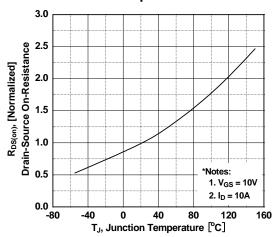


Figure 10. Maximum Safe Operating Area vs. Case Temperature - FCPF190N60

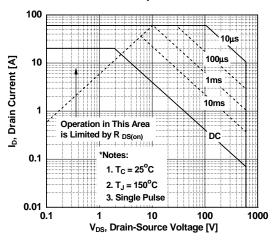
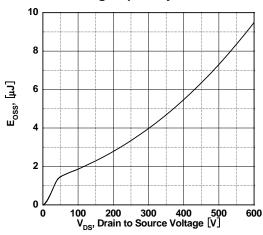


Figure 12. Eoss vs. Drain to Source Voltage Switching Capability



Typical Performance Characteristics (Continued)

Figure 13. Transient Thermal Response Curve - FCP190N60

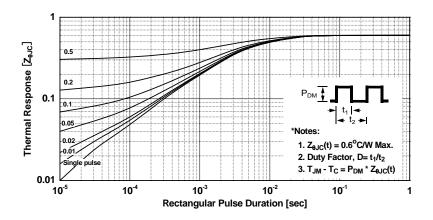
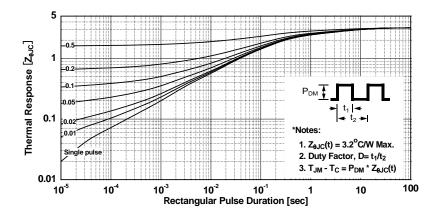
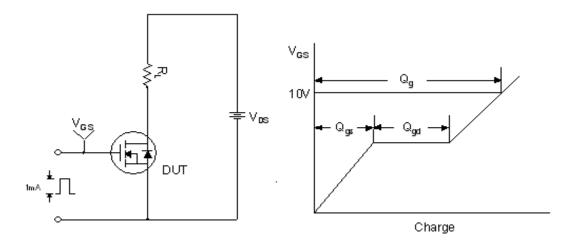


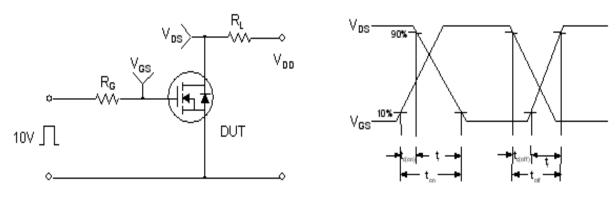
Figure 14. Transient Thermal Response Curve - FCPF190N60



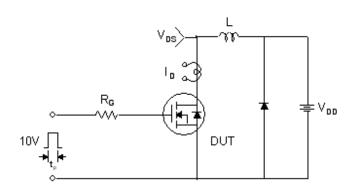
Gate Charge Test Circuit & Waveform

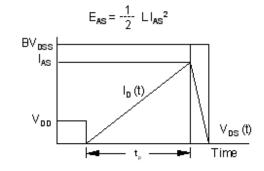


Resistive Switching Test Circuit & Waveforms

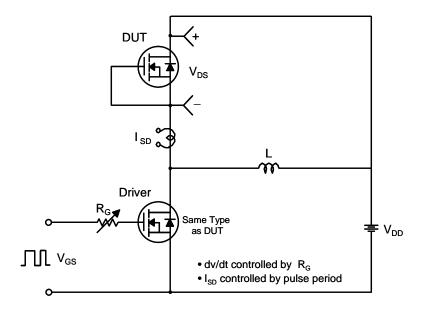


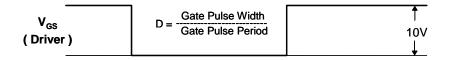
Unclamped Inductive Switching Test Circuit & Waveforms

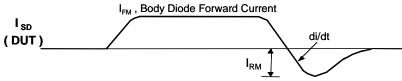




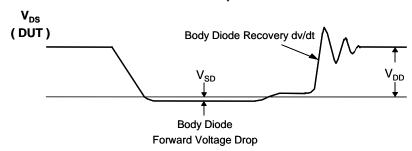
Peak Diode Recovery dv/dt Test Circuit & Waveforms





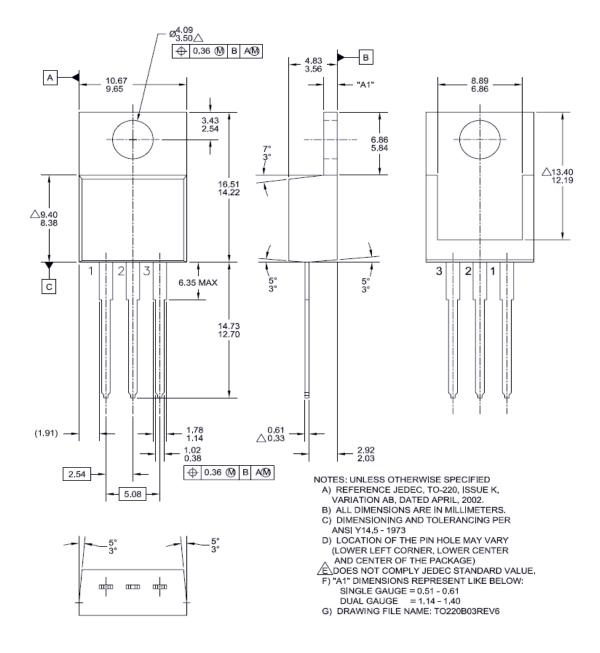


Body Diode Reverse Current



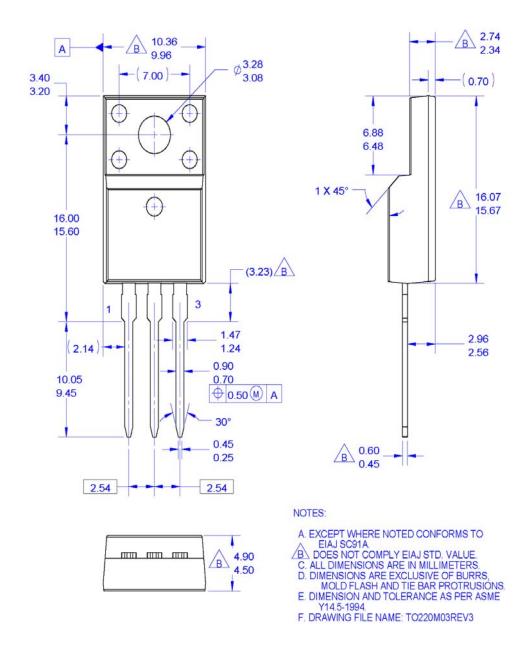
Mechanical Dimensions

TO-220



Package Dimensions

TO-220F (Retractable)



* Front/Back Side Isolation Voltage: AC 2500V

Dimensions in Millimeters





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